Amendments to the Claims

This listing of claims will replace all prior versions and listings of claims in the application.

Listing of Claims:

Claims 1 - 8 (canceled)

Claims 9-10 (canceled)

Claim 11 (withdrawn): A solder configuration, comprising a pad having a surface upon which an intermetallic boundary interface is disposed, said intermetallic boundary interface defining a separation between said pad and solder that forms part of a solder joint, said intermetallic boundary interface being characterized as non-planar and having a plurality of steps, whereby a crack forming in said solder is influenced to proceed along said interface with a non-planar, stepped path, thereby lengthening its travel, and preventing failure of said solder joint.

Claim 12 (withdrawn): A solder configuration, comprising a pad having a surface upon which an intermetallic boundary interface is disposed, said intermetallic boundary interface defining a separation between said pad and solder that forms part of a solder joint, said intermetallic boundary interface being characterized as non-planar and having a plurality of concentric interruptions, whereby a crack forming in said solder is influenced to proceed along

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said interface with a non-planar, interrupted path, thereby lengthening its travel, and preventing

failure of said solder joint.

Claim 13 (withdrawn): A solder configuration, comprising a pad having a surface upon

which an intermetallic boundary interface is disposed, said intermetallic boundary interface

defining a separation between said pad and solder that forms part of a solder joint, said

intermetallic boundary interface interface being characterized as non-planar and having a

plurality of interdigitated interruptions, whereby a crack forming in said solder is influenced to

proceed along said interface with a non-planar, interrupted path, thereby lengthening its travel,

and preventing failure of said solder joint.

Claim 14 (withdrawn): A solder configuration, comprising a pad having a surface on

which an intermetallic boundary interface is disposed, said intermetallic boundary interface

defining a separation between said pad and solder that forms part of a solder joint, said

intermetallic boundary interface being characterized as non-planar and having a cross-shaped

interruption, whereby a crack forming in said solder is influenced to proceed along said interface

with a non-planar, interrupted path thereby lengthening its travel, and preventing failure of said

solder joint.

Claims 15-16 (cancelled)

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Claim 17 (withdrawn) A solder joint for interconnecting an electronic chip to a substrate, comprising:

a metallic pad having a substantially planar lower surface for engaging said substrate and an upper surface extending in a first plane;

an obstacle formed along said upper surface and extending at least partially in a second plane vertically spaced from said first plane; and

solder coating at least a portion of both said upper surface and said obstacle, whereby micro-cracks forming in said solder adjacent to said upper surface will encounter said obstacle.

Claim 18 (withdrawn): The solder joint of claim 17, wherein said obstacle comprises a serpentine upper surface.

Claim 19 (withdrawn): The solder joint of claim 17, wherein said obstacle comprises an interdigitated strip projecting from said pad.

Claim 20 (withdrawn): The solder joint of claim 17, wherein said obstacle comprises a curved edge digit located in a central portion of said pad.

Claim 21 (withdrawn): The solder joint of claim 17, wherein said obstacle comprises at least two concentric walls extending outwardly from pad.

Claim 22 (withdrawn): The solder joint of claim 17, wherein said obstacle comprises a raised, cross-shaped member extending outwardly from pad.

Claim 23 (withdrawn): The solder joint of claim 17, wherein said obstacle comprises a plurality of cylindrical protrusions extending perpendicularly from said pad.

Claim 24 (currently amended): An electronic package including a semiconductor chip and a substrate A solder joint for interconnecting an electronic chip to a substrate, comprising:

a first metallic pad electrically and physically connected to said substrate and having a substantially planar first lower surface for engaging said substrate and a first upper surface including a first plurality of serpentine undulations extending upwardly;

a second metallic pad electrically and physically connected to said chip and having a substantially planar second upper surface for engaging said chip and a second lower surface including a second plurality of serpentine undulations extending downwardly; and solder interconnecting said first upper surface with said second lower surface, whereby micro-cracks forming in said solder adjacent to said first upper surface or said second lower surface will encounter said first plurality of serpentine undulations or and said second plurality of serpentine undulations, respectively.

Claim 25 (new): The package of claim 24, further comprising a first intermetallic boundary formed at the connection of said solder and said first upper surface, and a second intermetallic boundary formed at the connection of said solder and said second lower surface.

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Claim 26 (new): The package of claim 25, wherein said microcracks form in said first and second intermetallic boundaries.

Claim 27 (new): The package of claim 26, wherein said microcracks forming in said first and second intermetallic boundaries are redirected by said first upper surface and said second lower surface.

Claim 28 (new): The package of claim 26, wherein said microcracks forming in said first and second intermetallic boundaries are lengthened as a result of encountering said first upper surface and said second lower surface.